Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/037,168	SHIN ET AL.	
Examiner	Art Unit	
Steven HD Nguyen	2665	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARCH	H STRATEGY)	)
	DATE	EXMR
See East search history on the databases	10/15/2005	st